

## Terminal Voltage $\pm 3V$ or $\pm 5V$ , 128 Taps $I^2C$ Serial Interface

The Intersil ISL95711 is a digitally controlled potentiometer (XDCP). The device consists of a resistor array, wiper switches, a control section, and nonvolatile memory. The wiper position is controlled by a  $I^2C$  interface.

The potentiometer is implemented by a resistor array composed of 127 resistive elements and a wiper switching network. The wiper terminal can be connected to either end of the resistor array or at any one of the Tap Positions in between, providing 128 steps of resolution between  $R_L$  and  $R_H$ . The "position" of the wiper is determined by the value assigned to the volatile Wiper Register (WR). This register has an associated non-volatile Initial Value Register (IVR). The value stored in the IVR will be written into the WR at power-up, allowing wiper position recall after power interruption. The WR and the IVR can be directly written to and read from using standard  $I^2C$  interface protocol. The device is available in either a 10k $\Omega$  or 50k $\Omega$  version.

The device can be used as a three-terminal potentiometer or as a two-terminal variable resistor in a wide variety of applications including:

- Industrial and automotive control
- Parameter and bias adjustments
- Amplifier bias and control

## Ordering Information

| PART NUMBER                     | RESISTANCE OPTION ( $\Omega$ ) | TEMP RANGE ( $^{\circ}C$ ) | PACKAGE (Pb-Free) |
|---------------------------------|--------------------------------|----------------------------|-------------------|
| ISL95711WIU10Z<br>(Notes 1 & 2) | 10K                            | -40 to +85                 | 10-Ld MSOP        |
| ISL95711UIU10Z<br>(Notes 1 & 2) | 50K                            | -40 to +85                 | 10-Ld MSOP        |

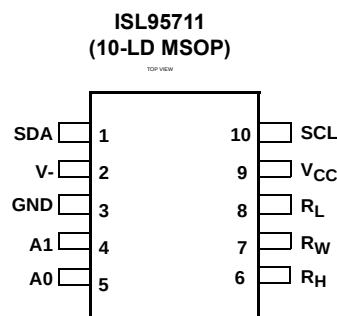
### NOTES:

1. Add "-T" suffix for tape and reel.
2. Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

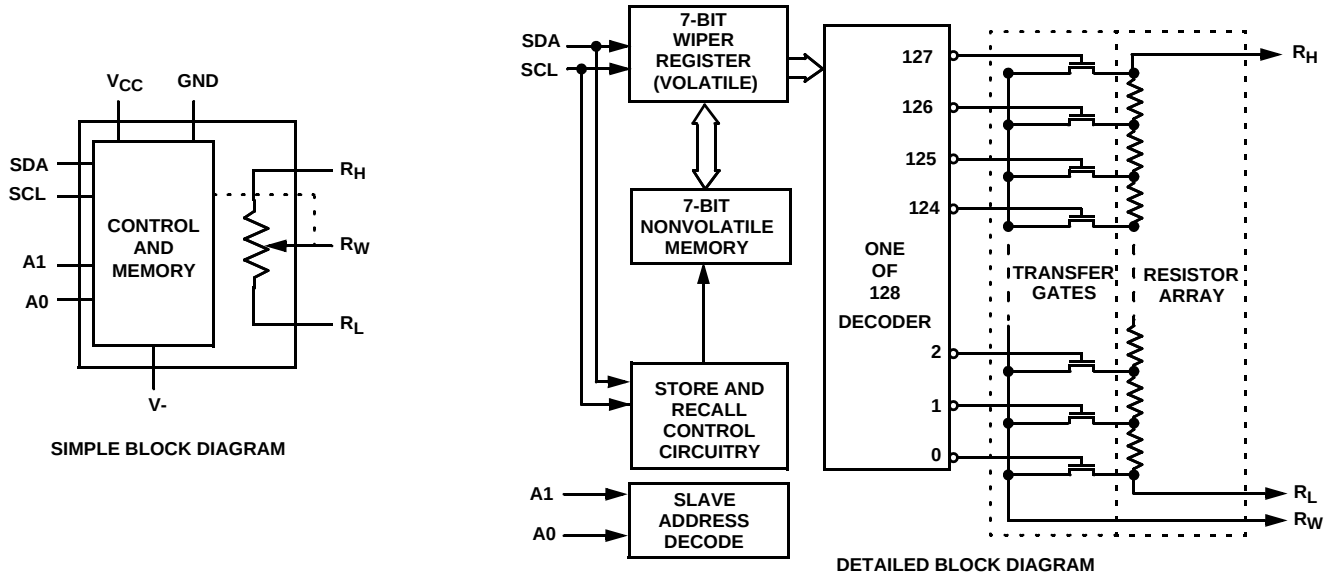
## Features

- Non-Volatile Solid-State Potentiometer
- $I^2C$  Serial Interface with Hardwire Slave Address Allows Up to Four Devices
- DCP Terminal Voltage, from  $V_-$  to  $V_{CC}$
- 128 Wiper Tap Points
  - Wiper position can be stored in nonvolatile memory and recalled on power-up
- 127 Resistive Elements
  - Typical tempco  $\pm 50\text{ppm}/^{\circ}C$
  - Ratiometric Tempco  $\pm 4\text{ppm}/^{\circ}C$
  - End to end resistance range  $\pm 20\%$
- Low Power CMOS
  - Standby current, 1 $\mu A$
  - Active current, 200 $\mu A$  max
  - $V_{CC}$  = 3V to 5.5V
  - $V_-$  = -3V to -5.5V
- High Reliability
  - Endurance, 200,000 data changes per bit
  - Register data retention, 50 years
- $R_{TOTAL}$  Values = 10k $\Omega$ , 50k $\Omega$
- Package
  - 10-lead MSOP
  - Pb-Free plus anneal available (RoHS compliant)

## Pinout



## Block Diagram



## Pin Descriptions

| PIN NUMBER | SYMBOL          | DESCRIPTION                                                                                                                                |
|------------|-----------------|--------------------------------------------------------------------------------------------------------------------------------------------|
| 1          | SDA             | Data I/O for I <sup>2</sup> C serial interface. It has an open drain output and may be wire or'd with other open drain active low outputs. |
| 2          | V-              | Negative supply voltage for the potentiometer wiper control.                                                                               |
| 3          | GND             | Ground.                                                                                                                                    |
| 4          | A1              | A1 and A0 are address select pins used to set the slave address for the I <sup>2</sup> C serial interface.                                 |
| 5          | A0              | A1 and A0 are address select pins used to set the slave address for the I <sup>2</sup> C serial interface.                                 |
| 6          | R <sub>H</sub>  | A fixed terminal for one end of the potentiometer resistor.                                                                                |
| 7          | R <sub>W</sub>  | The wiper terminal which is equivalent to the movable terminal of a potentiometer.                                                         |
| 8          | R <sub>L</sub>  | A fixed terminal for one end of the potentiometer resistor.                                                                                |
| 9          | V <sub>CC</sub> | Positive logic supply voltage                                                                                                              |
| 10         | SCL             | Clock input for the I <sup>2</sup> C serial interface.                                                                                     |

**Absolute Maximum Ratings**

Temperature under bias . . . . . -65°C to +135°C  
 Storage temperature . . . . . -65°C to +150°C  
 Voltage on SDA, SCL, A0, and A1  
 with respect to GND. . . . . -0.3 to  $V_{CC}+0.3V$   
 Voltage on V- (referenced to GND) . . . . . -6V  
 $\Delta V = |V_{(RH)} - V_{(RL)}|$  . . . . . 12V  
 Lead temperature (soldering 10 seconds) . . . . . 300°C  
 $I_W$  (10 seconds) . . . . .  $\pm 6mA$   
 $V_{CC}$  . . . . . -0.03V to 6V  
 $R_H, R_L, R_W$  . . . . . V- to  $V_{CC}$

**Recommended Operating Conditions**

Temperature Range (Industrial) . . . . . -40°C to +85°C  
 $V_{CC}$  . . . . . 3V to 5.5V  
 V- . . . . . -3V to -5.5V

**CAUTION:** Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device (at these or any other conditions above those listed in the operational sections of this specification) is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Analog Specifications**

Over recommended operating conditions unless otherwise stated.

| SYMBOL                                                                                                                                    | PARAMETER                           | TEST CONDITIONS                                                                 | MIN  | TYP<br>(Note 1) | MAX      | UNIT            |
|-------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------|---------------------------------------------------------------------------------|------|-----------------|----------|-----------------|
| $R_{TOTAL}$                                                                                                                               | $R_H$ to $R_L$ resistance           | W option                                                                        |      | 10              |          | k $\Omega$      |
|                                                                                                                                           |                                     | U option                                                                        |      | 50              |          | k $\Omega$      |
|                                                                                                                                           | $R_H$ to $R_L$ resistance tolerance |                                                                                 | -20  |                 | +20      | %               |
| $R_H, R_L$                                                                                                                                | $R_H, R_L$ terminal voltage         |                                                                                 | V-   |                 | $V_{CC}$ | V               |
| $R_W$                                                                                                                                     | Wiper resistance                    | V- = -5.5V; $V_{CC}$ = +5.5V, wiper current = $(V_{CC} - V_-)/R_{TOTAL}$        |      | 70              | 200      | $\Omega$        |
| $C_H/C_L/C_W$                                                                                                                             | Potentiometer Capacitance (Note 13) |                                                                                 |      | 10/10/<br>25    |          | pF              |
| $I_{LkgDCP}$                                                                                                                              | Leakage on $R_H, R_L, R_W$ pins     | Voltage at pins; V- to $V_{CC}$                                                 |      | 0.1             | 1        | $\mu A$         |
| <b>VOLTAGE DIVIDER MODE</b> (V- @ $R_L$ ; $V_{CC}$ @ $R_H$ ; Voltage at $R_W$ = $V_{RW}$ unloaded)                                        |                                     |                                                                                 |      |                 |          |                 |
| INL<br>(Note 6)                                                                                                                           | Integral non-linearity              |                                                                                 | -1   |                 | 1        | LSB<br>(Note 2) |
| DNL<br>(Note 5)                                                                                                                           | Differential non-linearity          | W, U options                                                                    | -0.5 |                 | 0.5      | LSB<br>(Note 2) |
| ZSerror<br>(Note 3)                                                                                                                       | Zero-scale error                    | W option                                                                        | 0    | 1               | 4        | LSB<br>(Note 2) |
|                                                                                                                                           |                                     | U option                                                                        | 0    | 0.5             | 2        |                 |
| FSerror<br>(Note 4)                                                                                                                       | Full-scale error                    | W option                                                                        | -4   | -1              | 0        | LSB<br>(Note 2) |
|                                                                                                                                           |                                     | U option                                                                        | -2   | -1              | 0        |                 |
| $TC_V$<br>(Notes 7, 13)                                                                                                                   | Ratiometric Temperature Coefficient | DCP Register set between 16 to 120d,<br>T = -40°C to +85°C                      |      | $\pm 4$         |          | ppm/°C          |
| <b>RESISTOR MODE</b> (Measurements between $R_W$ and $R_L$ with $R_H$ not connected, or between $R_W$ and $R_H$ with $R_L$ not connected) |                                     |                                                                                 |      |                 |          |                 |
| RINL<br>(Note 11)                                                                                                                         | Integral non-linearity              | DCP register set between 20 hex and 7F hex.<br>Monotonic over all tap positions | -1   |                 | 1        | MI<br>(Note 8)  |
| RDNL<br>(Note 10)                                                                                                                         | Differential non-linearity          | W and U options                                                                 | -0.5 |                 | 0.5      | MI<br>(Note 8)  |
|                                                                                                                                           |                                     |                                                                                 |      |                 |          |                 |
| Roffset<br>(Note 9)                                                                                                                       | Offset                              | DCP Register set to 00 hex, W option                                            | 0    | 2               | 5        | MI<br>(Note 8)  |
|                                                                                                                                           |                                     | DCP Register set to 00 hex, U option                                            | 0    | 0.5             | 2        |                 |
| $TC_R$<br>(Notes 12, 13)                                                                                                                  | Resistance Temperature Coefficient  | DCP register set between 16 and 127d,<br>T = -40°C to +85°C                     |      | $\pm 50$        |          | ppm/°C          |

**Operating Specifications** Over the recommended operating conditions unless otherwise specified.

| SYMBOL                 | PARAMETER                                     | TEST CONDITIONS                                                                                                  | MIN  | TYP<br>(Note 1) | MAX | UNITS         |
|------------------------|-----------------------------------------------|------------------------------------------------------------------------------------------------------------------|------|-----------------|-----|---------------|
| $I_{CC1}$              | $V_{CC}$ supply current, volatile write/read  | $f_{SCL} = 400\text{kHz}$ ; SDA = Open; (for $I^2C$ , Active, Read and Volatile Write States only)               |      |                 | 200 | $\mu\text{A}$ |
| $I_{V-1}$              | V- supply current, volatile write/read        | $f_{SCL} = 400\text{kHz}$ ; SDA = Open; (for $I^2C$ , Active, Read and Volatile Write States only)               | -100 |                 |     | $\mu\text{A}$ |
| $I_{CC2}$              | $V_{CC}$ supply current, non volatile write   | $f_{SCL} = 400\text{kHz}$ ; SDA = Open; (for $I^2C$ , Active, Nonvolatile Write State only)                      |      |                 | 200 | $\mu\text{A}$ |
| $I_{V-2}$              | V- supply current, nonvolatile write          | $f_{SCL} = 400\text{kHz}$ ; SDA = Open; (for $I^2C$ , Active, Nonvolatile Write State only)                      | -3   |                 |     | mA            |
| $I_{CCSB}$             | $V_{CC}$ current (standby)                    | $V_{CC} = +5.5\text{V}$ , $I^2C$ Interface in Standby State                                                      |      |                 | 1   | $\mu\text{A}$ |
|                        |                                               | $V_{CC} = +3.6\text{V}$ , $I^2C$ Interface in Standby State                                                      |      |                 | 1   | $\mu\text{A}$ |
| $I_{V-SB}$             | V- current (standby)                          | V- = -5.5V, $I^2C$ Interface in Standby State                                                                    | -5   |                 |     | $\mu\text{A}$ |
|                        |                                               | V- = -3.6V, $I^2C$ Interface in Standby State                                                                    | -2   |                 |     | $\mu\text{A}$ |
| $I_{LkgDig}$           | Leakage current, at pins SDA, SCL, A0, and A1 | Voltage at pin from GND to $V_{CC}$                                                                              | -10  |                 | 10  | $\mu\text{A}$ |
| $t_{DCP}$<br>(Note 13) | DCP wiper response time                       | SCL falling edge of last bit of DCP Data Byte to wiper change                                                    |      | 1               |     | $\mu\text{s}$ |
| $V_{por}$              | Power-on recall for both V- and $V_{CC}$      | V-                                                                                                               | -2.5 |                 |     | V             |
|                        |                                               | $V_{CC}$                                                                                                         |      |                 | 2.5 | V             |
| V-Ramp                 | V- ramp rate                                  |                                                                                                                  | 0.2  |                 |     | V/ms          |
| $t_D$<br>(Note 13)     | Power-up delay                                | $V_{CC}$ above $V_{por}$ , to DCP Initial Value Register recall completed, and $I^2C$ Interface in standby state |      | 3               |     | ms            |

**EEPROM SPECS**

|  |                  |                                     |         |  |  |        |
|--|------------------|-------------------------------------|---------|--|--|--------|
|  | EEPROM Endurance |                                     | 200,000 |  |  | Cycles |
|  | EEPROM Retention | Temperature $\leq 75^\circ\text{C}$ | 50      |  |  | Years  |

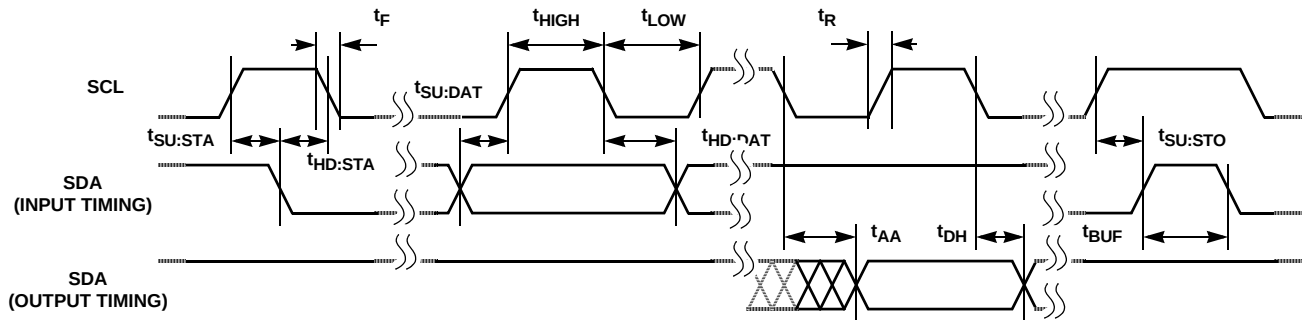
**SERIAL INTERFACE SPECS**

|                        |                                                                  |                                                                                                                             |                     |  |                    |     |
|------------------------|------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|---------------------|--|--------------------|-----|
| $V_{IL}$               | A0, A1, SDA, and SCL input buffer LOW voltage                    |                                                                                                                             | -0.3                |  | $0.3 \cdot V_{CC}$ | V   |
| $V_{IH}$               | A0, A1, SDA, and SCL input buffer HIGH voltage                   |                                                                                                                             | $0.7 \cdot V_{CC}$  |  | $V_{CC} + 0.3$     | V   |
| Hysteresis             | SDA and SCL input buffer hysteresis                              |                                                                                                                             | $0.05 \cdot V_{CC}$ |  |                    | V   |
| $V_{OL}$               | SDA output buffer LOW voltage, sinking 4mA                       |                                                                                                                             | 0                   |  | 0.4                | V   |
| $C_{pin}$<br>(Note 15) | A0, A1, SDA, and SCL pin capacitance                             |                                                                                                                             |                     |  | 10                 | pF  |
| $f_{SCL}$              | SCL frequency                                                    |                                                                                                                             |                     |  | 400                | kHz |
| $t_{IN}$               | Pulse width suppression time at SDA and SCL inputs               | Any pulse narrower than the max spec is suppressed.                                                                         |                     |  | 50                 | ns  |
| $t_{AA}$               | SCL falling edge to SDA output data valid                        | SCL falling edge crossing 30% of $V_{CC}$ , until SDA exits the 30% to 70% of $V_{CC}$ window.                              |                     |  | 900                | ns  |
| $t_{BUF}$              | Time the bus must be free before the start of a new transmission | SDA crossing 70% of $V_{CC}$ during a STOP condition, to SDA crossing 70% of $V_{CC}$ during the following START condition. | 1300                |  |                    | ns  |
| $t_{LOW}$              | Clock LOW time                                                   | Measured at the 30% of $V_{CC}$ crossing.                                                                                   | 1300                |  |                    | ns  |

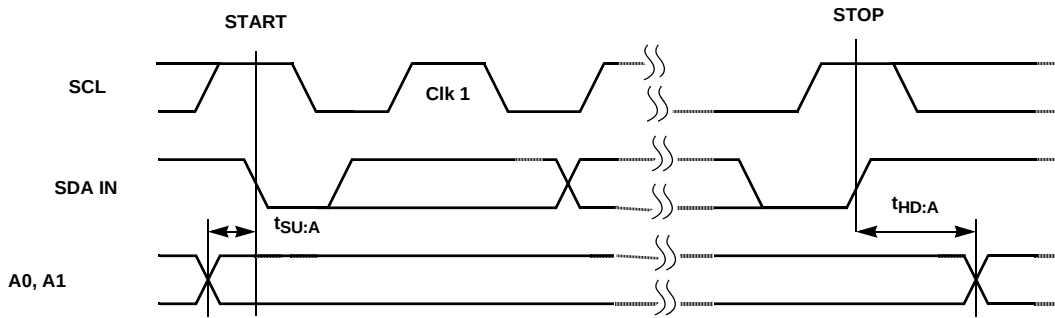
**Operating Specifications** Over the recommended operating conditions unless otherwise specified. (Continued)

| SYMBOL                        | PARAMETER                                 | TEST CONDITIONS                                                                                                                                                                       | MIN              | TYP<br>(Note 1) | MAX | UNITS      |
|-------------------------------|-------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|-----------------|-----|------------|
| $t_{\text{HIGH}}$             | Clock HIGH time                           | Measured at the 70% of $V_{\text{CC}}$ crossing.                                                                                                                                      | 600              |                 |     | ns         |
| $t_{\text{SU:STA}}$           | START condition setup time                | SCL rising edge to SDA falling edge. Both crossing 70% of $V_{\text{CC}}$ .                                                                                                           | 600              |                 |     | ns         |
| $t_{\text{HD:STA}}$           | START condition hold time                 | From SDA falling edge crossing 30% of $V_{\text{CC}}$ to SCL falling edge crossing 70% of $V_{\text{CC}}$ .                                                                           | 600              |                 |     | ns         |
| $t_{\text{SU:DAT}}$           | Input data setup time                     | From SDA exiting the 30% to 70% of $V_{\text{CC}}$ window, to SCL rising edge crossing 30% of $V_{\text{CC}}$                                                                         | 100              |                 |     | ns         |
| $t_{\text{HD:DAT}}$           | Input data hold time                      | From SCL rising edge crossing 70% of $V_{\text{CC}}$ to SDA entering the 30% to 70% of $V_{\text{CC}}$ window.                                                                        | 0                |                 |     | ns         |
| $t_{\text{SU:STO}}$           | STOP condition setup time                 | From SCL rising edge crossing 70% of $V_{\text{CC}}$ , to SDA rising edge crossing 30% of $V_{\text{CC}}$ .                                                                           | 600              |                 |     | ns         |
| $t_{\text{HD:STO}}$           | STOP condition setup time                 | From SDA rising edge to SCL falling edge. Both crossing 70% of $V_{\text{CC}}$ .                                                                                                      | 600              |                 |     | ns         |
| $t_{\text{DH}}$               | Output data hold time                     | From SCL falling edge crossing 30% of $V_{\text{CC}}$ , until SDA enters the 30% to 70% of $V_{\text{CC}}$ window.                                                                    | 0                |                 |     | ns         |
| $t_{\text{R}}$<br>(Note 15)   | SDA and SCL rise time                     | From 30% to 70% of $V_{\text{CC}}$                                                                                                                                                    | $20 + 0.1 * C_b$ |                 | 250 | ns         |
| $t_{\text{F}}$<br>(Note 15)   | SDA and SCL fall time                     | From 70% to 30% of $V_{\text{CC}}$                                                                                                                                                    | $20 + 0.1 * C_b$ |                 | 250 | ns         |
| $C_b$<br>(Note 15)            | Capacitive loading of SDA or SCL          | Total on-chip and off-chip                                                                                                                                                            | 10               |                 | 400 | pF         |
| $R_{\text{pu}}$<br>(Note 15)  | SDA and SCL bus pull-up resistor off-chip | Maximum is determined by $t_{\text{R}}$ and $t_{\text{F}}$ .<br>For $C_b = 400\text{pF}$ , max is about 2~2.5k $\Omega$ .<br>For $C_b = 40\text{pF}$ , max is about 15~20k $\Omega$ . | 1                |                 |     | k $\Omega$ |
| $t_{\text{WC}}$<br>(Notes 14) | Non-volatile Write cycle time             |                                                                                                                                                                                       |                  | 12              | 20  | ms         |
| $t_{\text{SU:A}}$             | A0, A1 setup time                         | Before START condition                                                                                                                                                                | 600              |                 |     | ns         |
| $t_{\text{HD:A}}$             | A0, A1 hold time                          | After STOP condition                                                                                                                                                                  | 600              |                 |     | ns         |

**SDA vs SCL Timing**



## A0, A1 Pin Timing



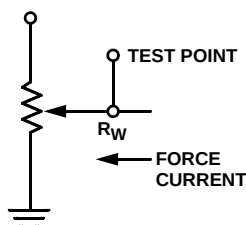
### NOTES:

1. Typical values are for  $T_A = 25^\circ\text{C}$  and  $\pm 5\text{V}$  supply voltage.
2. LSB:  $[V(RW)_{127} - V(RW)_0] / 127$ .  $V(RW)_{127}$  and  $V(RW)_0$  are  $V(RW)$  for the DCP register set to 7F hex and 00 hex respectively. LSB is the incremental voltage when changing from one tap to an adjacent tap.
3. ZS error =  $(V(RW)_0 - V_-) / \text{LSB}$ .
4. FS error =  $[V(RW)_{127} - V_{CC}] / \text{LSB}$ .
5.  $\text{DNL} = [V(RW)_i - V(RW)_{i-1}] / \text{LSB} - 1$ , for  $i = 1$  to 127.  $i$  is the DCP register setting.
6.  $\text{INL} = V(RW)_i - (i \cdot \text{LSB} - V(RW)_0)$  for  $i = 1$  to 127.
7. 
$$TC_V = \frac{\text{Max}(V(RW)_i) - \text{Min}(V(RW)_i)}{[\text{Max}(V(RW)_i) + \text{Min}(V(RW)_i)] / 2} \times \frac{10^6}{125^\circ\text{C}}$$

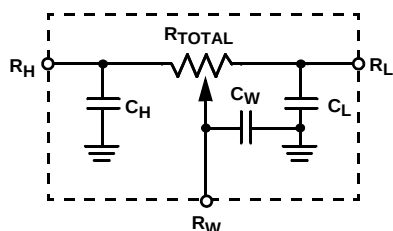
for  $i = 16$  to 120 decimal.  $\text{Max}()$  is the maximum value of the wiper voltage and  $\text{Min}()$  is the minimum value of the wiper voltage over the temperature range.
8.  $\text{MI} = |R_{127} - R_0| / 127$ .  $R_{127}$  and  $R_0$  are the measured resistances for the DCP register set to 127d and 0 respectively.
9.  $\text{Roffset} = R_0 / \text{MI}$ , when measuring between  $R_W$  and  $R_L$ .  
 $\text{Roffset} = R_{127} / \text{MI}$ , when measuring between  $R_W$  and  $R_H$ .
10.  $\text{RDNL} = (R_i - R_{i-1}) / \text{MI}$ , for  $i = 16$  to 127.
11.  $\text{RINL} = [R_i - (\text{MI} \cdot i) - R_0] / \text{MI}$ , for  $i = 16$  to 127.
12. 
$$TC_R = \frac{[\text{Max}(R_i) - \text{Min}(R_i)]}{[\text{Max}(R_i) + \text{Min}(R_i)] / 2} \times \frac{10^6}{125^\circ\text{C}}$$

for  $i = 16$  to 127d.  $\text{Max}()$  is the maximum value of the resistance and  $\text{Min}()$  is the minimum value of the resistance over the temperature range.
13. This parameter is not 100% tested.
14.  $t_{WC}$  is the minimum cycle time to be allowed for any non-volatile Write by the user, unless Acknowledge Polling is used. It is the time from a valid STOP condition at the end of a Write sequence of a  $I^2\text{C}$  serial interface Write operation, to the end of the self-timed internal non-volatile write cycle.
15. These are  $I^2\text{C}$  specific parameters and are not directly tested, however they are used during device testing to validate device specification.

## Test Circuit



## Equivalent Circuit



## Pin Descriptions

### Potentiometer Pins

#### $R_H$ AND $R_L$

The high ( $R_H$ ) and low ( $R_L$ ) terminals of the ISL95711 are equivalent to the fixed terminals of a mechanical potentiometer.  $R_H$  and  $R_L$  are referenced to the relative position of the wiper and not the voltage potential on the terminals. With  $WR$  set to 127, the wiper will be closest to  $R_H$ , and with the  $WR$  set to 00, the wiper is closest to  $R_L$ .

#### $R_W$

$R_W$  is the wiper terminal and is equivalent to the movable terminal of a mechanical potentiometer. The position of the wiper within the array is determined by the  $WR$ .

### Bus Interface Pins

#### SERIAL DATA INPUT/OUTPUT (SDA)

The SDA is a bidirectional serial data input/output pin for the I<sup>2</sup>C interface. It receives device address, operation code, wiper register address and data from a I<sup>2</sup>C external master device at the rising edge of the serial clock SCL, and it shifts out data after each falling edge of the serial clock SCL.

SDA requires an external pull-up resistor, since it's an open drain input/output.

#### SERIAL CLOCK (SCL)

This input is the serial clock of the I<sup>2</sup>C serial interface.

SCL requires an external pull-up resistor, since it's an open drain input.

#### DEVICE ADDRESS (A1-A0)

The Address inputs are used to set the least significant 2 bits of the 7-bit I<sup>2</sup>C interface slave address. A match in the slave

address serial data stream must be made with the Address input pins in order to initiate communication with the ISL95711. A maximum of 4 ISL95711 devices may occupy the I<sup>2</sup>C serial bus.

## Principles of Operation

The ISL95711 is an integrated circuit incorporating one DCP with its associated register, non-volatile memory, and the I<sup>2</sup>C serial interface providing direct communication between a host and the potentiometer and memory. The resistor array is comprised of individual resistors connected in series. At either end of the array and between each resistor is an electronic switch that transfers the potential at that point to the wiper.

The wiper, when at either fixed terminal, acts like its mechanical equivalent and does not move beyond the last position. That is, the counter does not wrap around when clocked to either extreme.

The electronic switches on the device operate in a "make before break" mode when the wiper changes tap positions.

When the device is powered-down, the last value stored in the IVR will be maintained in the nonvolatile memory. When power is restored, the contents of the IVR are recalled and the wiper is set to that value.

The ISL95711 has dual supplies,  $V_{CC}$  and  $V_-$ . For proper operation of the chip, it is recommended both power supplies ramp up simultaneously to their final values within 20ms. The chip design gives priority to the  $V_-$  supply stabilization and then looks at  $V_{CC}$  stabilization. As the  $V_-$  supply goes below -2.5V, the  $R_W$  pin goes to the default code of 64. As  $V_{CC}$  also exceeds 2.5V (after  $V_- < -2.5V$ ), the  $R_W$  pin goes to the code stored in the EEPROM memory value (this is referred as power on recall).

### DCP Description

The DCP is implemented with a combination of resistor elements and CMOS switches. The physical ends of the DCP are equivalent to the fixed terminals of a mechanical potentiometer ( $R_H$  and  $R_L$  pins). The  $R_W$  pin is connected to intermediate nodes, and is equivalent to the wiper terminal of a mechanical potentiometer. The position of the wiper terminal is controlled by a 7-bit volatile Wiper Register ( $WR$ ). When the  $WR$  contains all zeroes (00h), the wiper terminal ( $R_W$ ) is closest to its "Low" terminal ( $R_L$ ). When the  $WR$  contains all ones (7Fh), the wiper terminal ( $R_W$ ) is closest to its "High" terminal ( $R_H$ ). As the value of the  $WR$  increases from all zeroes (00h) to all ones (7Fh), the wiper moves monotonically from the position closest to  $R_L$  to the position closest to  $R_H$ . At the same time, the resistance between  $R_W$  and  $R_L$  increases monotonically, while the resistance between  $R_H$  and  $R_W$  decreases monotonically.

While the ISL95711 is being powered up, the  $WR$  is reset to 40h (64 decimal), which locates the  $R_W$  at the center

between  $R_L$  and  $R_H$ . Soon after the power supply voltage becomes large enough for reliable non-volatile memory reading ( $\sim \pm 2.5V$ ), the ISL95711 reads the value stored on a non-volatile Initial Value Register (IVR) and loads it into the WR.

The WR and IVR can be read or written directly using the I<sup>2</sup>C serial interface as described in the following sections.

### Memory Description

The ISL95711 contains 1 non-volatile byte known as the Initial Value Register (IVR). It is accessed by the I<sup>2</sup>C interface operations with Address 00h. The IVR contains the value which is loaded into the Volatile Wiper Register (WR) at power-up.

The volatile WR, and the non-volatile IVR of a DCP are accessed with the same address.

The Access Control Register (ACR) determines which byte at address 00h is accessed (IVR or WR). The volatile ACR must be set as follows:

When the ACR is all zeroes, which is the default at power-up:

- A read operation to address 0 outputs the value of the non-volatile IVR.
- A write operation to address 0 writes the same value to the WR and IVR of the corresponding DCP.

When the ACR is 80h:

- A read operation to address 0 outputs the value of the volatile WR.
- A write operation to address 0 only writes to the corresponding volatile WR.

It is not possible to write to an IVR without writing the same value to its corresponding WR.

00h and 80h are the only values that should be written to address 2. All other values are reserved and must not be written to address 2.

TABLE 1. MEMORY MAP

| ADDRESS | NON-VOLATILE | VOLATILE |
|---------|--------------|----------|
| 2       | -            | ACR      |
| 1       | Reserved     |          |
| 0       | IVR          | WR       |

WR: Wiper Register, IVR: Initial value Register.

The ISL95711 is pre-programmed with 40h in the IVR.

### I<sup>2</sup>C Serial Interface

The ISL95711 supports a bidirectional bus oriented protocol. The protocol defines any device that sends data onto the bus as a transmitter and the receiving device as the receiver. The device controlling the transfer is a master and the

device being controlled is the slave. The master always initiates data transfers and provides the clock for both transmit and receive operations. Therefore, the ISL95711 operates as a slave device in all applications.

All communication over the I<sup>2</sup>C interface is conducted by sending the MSB of each byte of data first.

### Protocol Conventions

Data states on the SDA line can change only during SCL LOW periods. SDA state changes during SCL HIGH are reserved for indicating START and STOP conditions (See Figure 1). On power-up of the ISL95711 the SDA pin is in the input mode.

All I<sup>2</sup>C interface operations must begin with a START condition, which is a HIGH to LOW transition of SDA while SCL is HIGH. The ISL95711 continuously monitors the SDA and SCL lines for the START condition and does not respond to any command until this condition is met (See Figure 1). A START condition is ignored during the power-up sequence and during internal non-volatile write cycles.

All I<sup>2</sup>C interface operations must be terminated by a STOP condition, which is a LOW to HIGH transition of SDA while SCL is HIGH (See Figure 1). A STOP condition at the end of a read operation, or at the end of a write operation to volatile bytes only places the device in its standby mode. A STOP condition during a write operation to a non-volatile byte, initiates an internal non-volatile write cycle. The device enters its standby state when the internal non-volatile write cycle is completed.

An ACK, Acknowledge, is a software convention used to indicate a successful data transfer. The transmitting device, either master or slave, releases the SDA bus after transmitting eight bits. During the ninth clock cycle, the receiver pulls the SDA line LOW to acknowledge the reception of the eight bits of data (See Figure 2).

The ISL95711 responds with an ACK after recognition of a START condition followed by a valid Identification Byte, and once again after successful receipt of an Address Byte. The ISL95711 also responds with an ACK after receiving a Data Byte of a write operation. The master must respond with an ACK after receiving a Data Byte of a read operation.

A valid Identification Byte contains 01010 as the five MSBs, and the following two bits matching the logic values present at pins A1, and A0. The LSB is in the Read/Write bit. Its value is "1" for a Read operation, and "0" for a Write operation. (See Table 2.)

TABLE 2. IDENTIFICATION BYTE FORMAT

Logic values at pins A1, and A0 respectively

|       |   |   |   |   |       |    |     |
|-------|---|---|---|---|-------|----|-----|
| 0     | 1 | 0 | 1 | 0 | A1    | A0 | R/W |
| (MSB) |   |   |   |   | (LSB) |    |     |



## Write Operation

A Write operation requires a START condition, followed by a valid Identification Byte, a valid Address Byte, a Data Byte, and a STOP condition. After each of the three bytes, the ISL95711 responds with an ACK. At this time, if the Data Byte is to be written only to volatile registers, then the device enters its standby state. If the Data Byte is to be written also to non-volatile memory, the ISL95711 begins its internal write cycle to non-volatile memory. During the internal non-volatile write cycle, the device ignores transitions at the SDA and SCL pins, and the SDA output is at a high impedance state. When the internal non-volatile write cycle is completed, the ISL95711 enters its standby state (See Figure 3).

The byte at address 02h determines if the Data Byte is to be written to volatile or both volatile and non-volatile. (See "Memory Description" on page 8.)

## Data Protection

A STOP condition acts as a protection of non-volatile memory. A valid Identification Byte, Address Byte, and total number of SCL pulses act as a protection of both volatile and non-volatile registers. During a Write sequence, the Data Byte is loaded into an internal shift register as it is

received. If the Address Byte is 0 or 2, the Data Byte is transferred to the Wiper Register (WR) or to the Access Control Register respectively, at the falling edge of the SCL pulse that loads the last bit (LSB) of the Data Byte. If the Address Byte is 0, and the Access Control Register is all zeros (default), then the STOP condition initiates the internal write cycle to non-volatile memory.

## Read Operation

A Read operation consists of a three byte instruction followed by one or more Data Bytes (See Figure 4). The master initiates the operation issuing the following sequence: a START, the Identification byte with the R/W bit set to "0", an Address Byte, a second START, and a second Identification byte with the R/W bit set to "1". After each of the three bytes, the ISL95711 responds with an ACK; then the ISL95711 transmits the Data Byte. The master then terminates the read operation (issuing a STOP condition) following the last bit of the Data Byte (See Figure 4).

The byte at address 02h determines if the Data Bytes being read are from volatile or non-volatile memory. (See "Memory Description".)

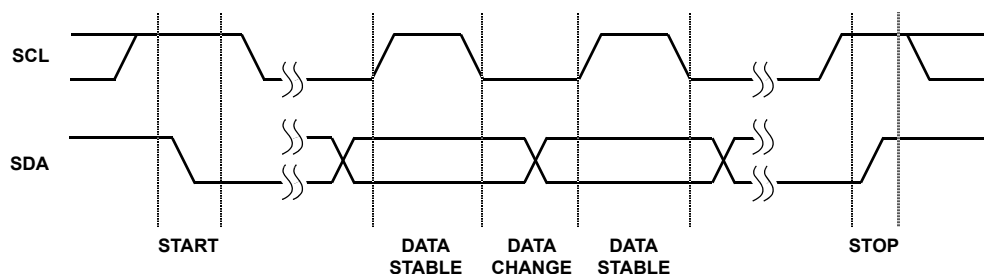


FIGURE 1. VALID DATA CHANGES, START, AND STOP CONDITIONS

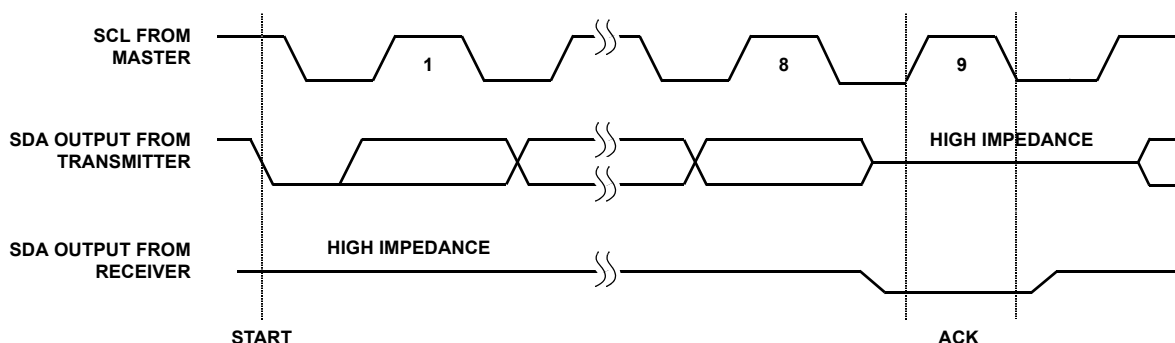


FIGURE 2. ACKNOWLEDGE RESPONSE FROM RECEIVER

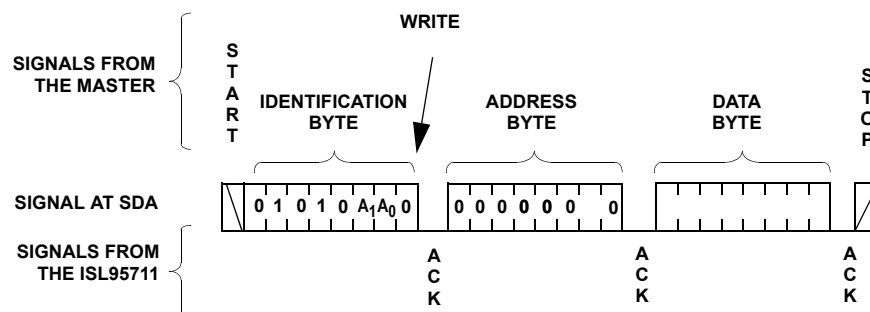


FIGURE 3. BYTE WRITE SEQUENCE

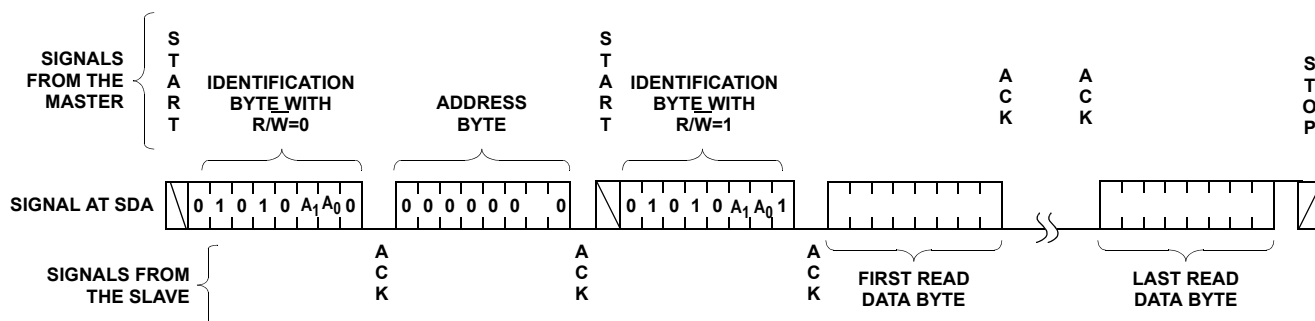


FIGURE 4. READ SEQUENCE

## Communicating with the ISL95711

There are 3 register addresses in the ISL95711, of which two can be used. Address 00h and address 02h are used to control the device. Address 01h is reserved and should not be used. Address 00h contains the non-volatile Initial Value Register (IVR), and the volatile Wiper Register (WR). Address 02h contains only a volatile word and is used as a pointer to either the IVR or WR. See Table 1.

### Register Descriptions: Access Control

The Access Control Register (ACR) is volatile and is at address 02h. It is 8-bits, and only the MSB is significant, all other bits should be zero (0). The ACR controls which word is accessed at register 00h as follows:

00h = Nonvolatile IVR

80h = Volatile WR

All other bits of the ACR should be written to as zeros. Only the MSB can be either 0 or 1. Power-up default for this address is 00h.

### Register Description: IVR and WR

The ISL95711 has a single potentiometer. The wiper of the potentiometer is controlled directly by the WR. Writes and reads can be made directly to this register to control and monitor the wiper position without any non-volatile memory changes. This is done by setting address 02h to data 80h, then writing the data.

The non-volatile IVR stores the power-up value of the wiper. On power-up, the contents of the IVR are transferred to the WR.

To write to the IVR, first address 02h is set to data 00h, then the data is written. Writing a new value to the IVR register will set a new power-up position for the wiper. Also, writing to this register will load the same value into the WR as the IVR. So, if a new value is loaded into the IVR, not only will the non-volatile IVR change, but the WR will also contain the same value after the write, and the wiper position will change. Reading from the IVR will not change the WR, if its contents are different.

**Example 1****Writing a new value (77h) to the IVR:**

Write to ACR first

|   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | A | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | A | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | A |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|

Then, write to IVR

|   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | A | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | A | 0 | 1 | 1 | 1 | 0 | 1 | 1 | 1 | A |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|

NOTE: The WR will also reflect this new value since both registers get written to at the same time)

**Example 2****Reading from the WR:**

Write to the ACR first (to index the WR)

|   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | A | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | A | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | A |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|

Then, Set the WR address

|   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | A | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | A |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|

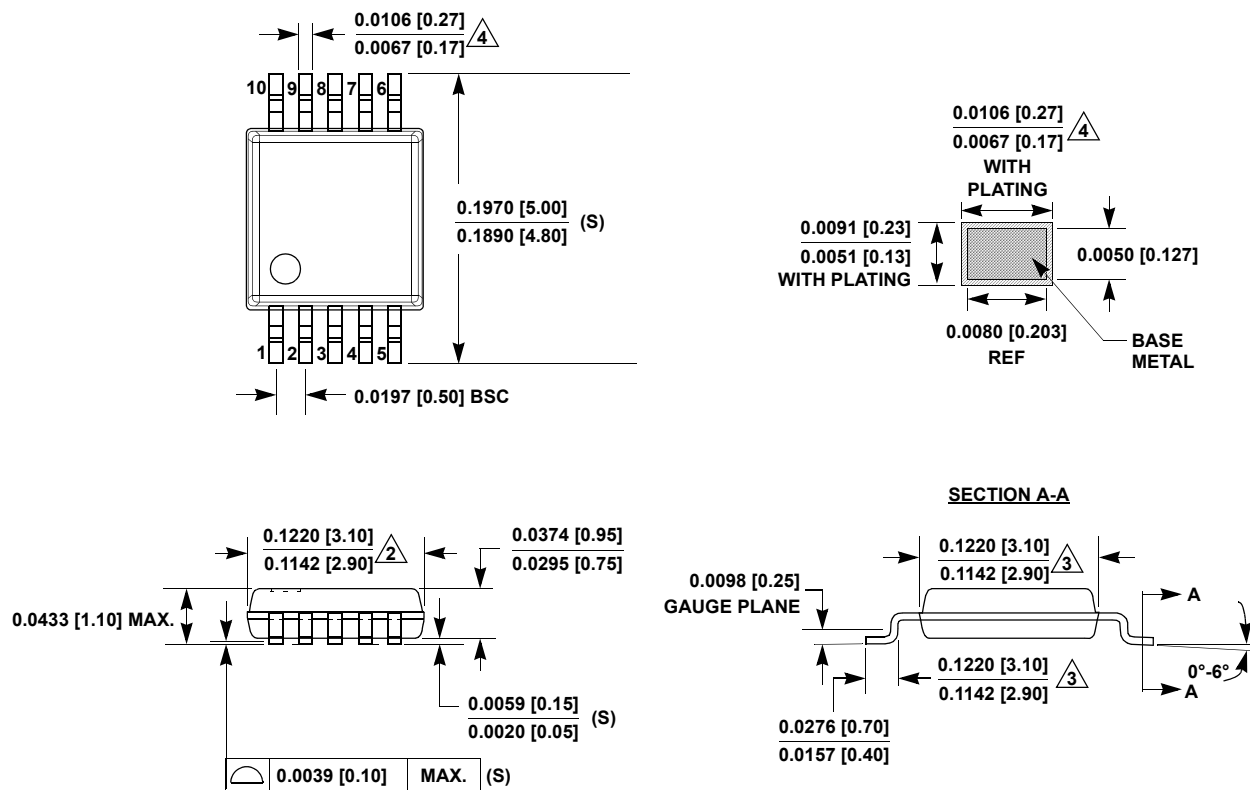
Read from the WR

|   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 1 | A | x | x | x | x | x | x | x | x | x |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|

NOTE: A = acknowledge, x = data bit read

## MSOP Packaging Information

## 10 Lead MSOP, Package Code



## NOTES:

- Package dimensions conform to JEDEC specification MO-187BA.
- ② Does not include mold flash, protrusion or gate burrs, mold flash protrusions or gate burrs shall not exceed 0.15 mm per side.
- ③ Does not include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.15 mm per side.
- ④ Does not include dambar protrusion. Allowable dambar protrusion shall be 0.8 mm.
- Lead span/stand-off height/coplanarity are considered as special characteristics.
- Controlling dimensions in inches [mm].

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